

## DS90C401

## **Dual Low Voltage Differential Signaling (LVDS) Driver**

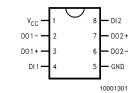
## **General Description**

# The DS90C401 is a dual driver device optimized for high data rate and low power applications. This device along with the DS90C402 provides a pair chip solution for a dual high speed point-to-point interface. The DS90C401 is a current mode driver allowing power dissipation to remain low even at high frequency. In addition, the short circuit fault current is also minimized. The device is in a 8 lead small outline package. The differential driver outputs provides low EMI with its low output swings typically 340 mV.

#### **Features**

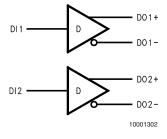
- Ultra low power dissipation
- Operates above 155.5 Mbps
- Standard TIA/EIA-644
- 8 Lead SOIC Package saves space
- Low Differential Output Swing typical 340 mV

#### **Connection Diagram**



Order Number DS90C401M See NS Package Number M08A

## **Functional Diagram**



## **Absolute Maximum Ratings** (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Short Circuit Duration

 $(D_{OUT+}, D_{OUT-})$  Continuous

Maximum Package Power Dissipation @ +25°C

M Package 1068 mW

Derate M Package 8.5 mW/°C above +25°C

Storage Temperature Range -65°C to +150°C

Lead Temperature Range

Soldering (4 sec.) +260°C

Maximum Junction

Temperature +150°C

**ESD** Rating

(HBM, 1.5 kΩ, 100 pF)  $\ge$  3,500V (EIAJ, 0 Ω, 200 pF)  $\ge$  250V

# Recommended Operating Conditions

	Min	Тур	Max	Units	
Supply Voltage $(V_{CC})$	+4.5	+5.0	+5.5	V	
Operating Free Air					
Temperature (T <sub>A</sub> )	-40	+25	+85	°C	

#### **Electrical Characteristics**

Over supply voltage and operating temperature ranges, unless otherwise specified. (Notes 2, 3)

Symbol	Parameter	Conditions	Pin	Min	Тур	Max	Units
V <sub>OD1</sub>	Differential Output Voltage	$R_L = 100\Omega \ (Figure \ 1)$	D <sub>OUT</sub> ,	250	340	450	mV
$\Delta V_{OD1}$	Change in Magnitude of V <sub>OD1</sub> for		D <sub>OUT+</sub>		4	35	lmVl
	Complementary Output States						
Vos	Offset Voltage			1.125	1.25	1.375	V
$\Delta V_{OS}$	Change in Magnitude of V <sub>OS</sub> for				5	25	lmVl
	Complementary Output States						
V <sub>OH</sub>	Output Voltage High	$R_L = 100\Omega$			1.41	1.60	V
V <sub>OL</sub>	Output Voltage Low			0.90	1.07		V
I <sub>os</sub>	Output Short Circuit Current	V <sub>OUT</sub> = 0V (Note 8)			-3.5	-5.0	mA
V <sub>IH</sub>	Input Voltage High		D <sub>IN</sub>	2.0		V <sub>CC</sub>	V
V <sub>IL</sub>	Input Voltage Low			GND		0.8	V
I <sub>I</sub>	Input Current	$V_{IN} = V_{CC}$ , GND, 2.5V or 0.4V		-10	±1	+10	μΑ
V <sub>CL</sub>	Input Clamp Voltage	I <sub>CL</sub> = -18 mA		-1.5	-0.8		V
I <sub>CC</sub>	No Load Supply Current	D <sub>IN</sub> = V <sub>CC</sub> or GND	V <sub>CC</sub>		1.7	3.0	mA
		D <sub>IN</sub> = 2.5V or 0.4V			3.5	5.5	mA
I <sub>CCL</sub>	Loaded Supply Current	$R_L = 100\Omega$ All Channels	]		8	14.0	mA
		$V_{IN} = V_{CC}$ or GND (all inputs)					

## **Switching Characteristics**

 $V_{CC}$  = +5.0V ±10%,  $T_A$  = -40°C to +85°C (Notes 3, 4, 5, 6, 9)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
t <sub>PHLD</sub>	Differential Propagation Delay High to Low	$R_L = 100\Omega, C_L = 5 pF$	0.5	2.0	3.5	ns
t <sub>PLHD</sub>	Differential Propagation Delay Low to High	(Figure 2 and Figure 3)	0.5	2.1	3.5	ns
t <sub>SKD</sub>	Differential Skew  tphld - tplhd		0	80	900	ps
t <sub>SK1</sub>	Channel-to-Channel Skew (Note 4)		0	0.3	1.0	ns
t <sub>SK2</sub>	Chip to Chip Skew (Note 5)				3.0	ns
t <sub>TLH</sub>	Rise Time			0.35	2.0	ns
t <sub>THL</sub>	Fall Time			0.35	2.0	ns

## **Parameter Measurement Information**

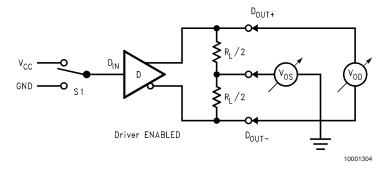


FIGURE 1. Driver  $\rm V_{OD}$  and  $\rm V_{OS}$  Test Circuit

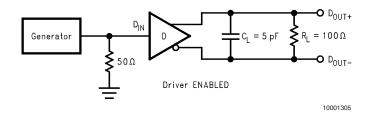


FIGURE 2. Driver Propagation Delay and Transition Time Test Circuit

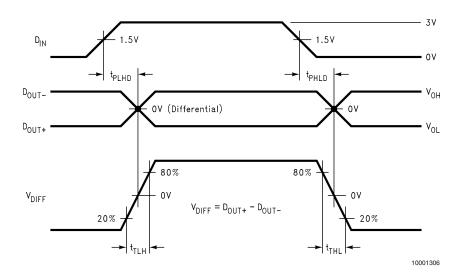


FIGURE 3. Driver Propagation Delay and Transition Time Waveforms

## **Typical Application**

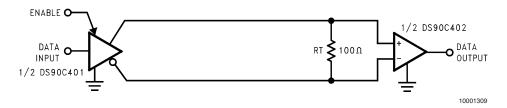


FIGURE 4. Point-to-Point Application

## **Applications Information**

LVDS drivers and receivers are intended to be primarily used in an uncomplicated point-to-point configuration as is shown in Figure 4. This configuration provides a clean signaling environment for the quick edge rates of the drivers. The receiver is connected to the driver through a balanced media which may be a standard twisted pair cable, a parallel pair cable, or simply PCB traces. Typically, the characteristic impedance of the media is in the range of  $100\Omega$ . A termination resistor of  $100\Omega$  should be selected to match the media, and is located as close to the receiver input pins as possible. The termination resistor converts the current sourced by the driver into a voltage that is detected by the receiver. Other configurations are possible such as a multi-receiver configuration, but the effects of a mid-stream connector(s), cable stub(s), and other impedance discontinuities as well as ground shifting, noise margin limits, and total termination loading must be taken into account.

The DS90C401 differential line driver is a balanced current source design. A current mode driver, generally speaking has a high output impedance and supplies a constant current for a range of loads (a voltage mode driver on the other hand supplies a constant voltage for a range of loads). Current is switched through the load in one direction to produce a logic state and in the other direction to produce the other logic state. The typical output current is mere 3.4 mA, a minimum of 2.5 mA, and a maximum of 4.5 mA. The

current mode **requires** (as discussed above) that a resistive termination be employed to terminate the signal and to complete the loop as shown in *Figure 4*. AC or unterminated configurations are not allowed. The 3.4 mA loop current will develop a differential voltage of 340 mV across the  $100\Omega$  termination resistor which the receiver detects with a 240 mV minimum differential noise margin neglecting resistive line losses (driven signal minus receiver threshold (340 mV - 100 mV = 240 mV)). The signal is centered around +1.2V (Driver Offset,  $\rm V_{OS}$ ) with respect to ground as shown in *Figure 5*. Note that the steady-state voltage ( $\rm V_{SS}$ ) peak-topeak swing is twice the differential voltage ( $\rm V_{OD}$ ) and is typically 680 mV.

The current mode driver provides substantial benefits over voltage mode drivers, such as an RS-422 driver. Its quiescent current remains relatively flat versus switching frequency. Whereas the RS-422 voltage mode driver increases exponentially in most case between 20 MHz–50 MHz. This is due to the overlap current that flows between the rails of the device when the internal gates switch. Whereas the current mode driver switches a fixed current between its output without any substantial overlap current. This is similar to some ECL and PECL devices, but without the heavy static  $I_{\rm CC}$  requirements of the ECL/PECL designs. LVDS requires > 80% less current than similar PECL devices. AC specifications for the driver are a tenfold improvement over other existing RS-422 drivers.

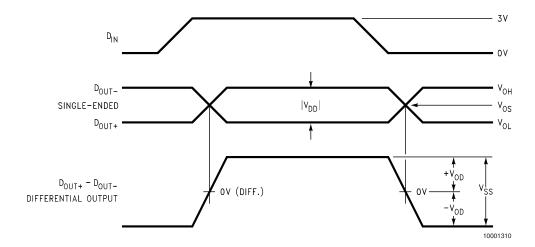


FIGURE 5. Driver Output Levels

## **Pin Descriptions**

**TABLE 1. Device Pin Descriptions** 

Pin No.	Name	Description	
4, 8	D <sub>IN</sub>	TTL/CMOS driver input pins	
3, 7	D <sub>OUT+</sub>	Non-inverting driver output pin	
2, 6	D <sub>OUT</sub>	Inverting driver output pin	
5	GND	Ground pin	
1	V <sub>CC</sub>	Positive power supply pin,	
		+5.0V ± 10%	

## **Ordering Information**

Operating	Package Type/	Order Number
Temperature	Number	
-40°C to +85°C	SOP/M08A	DS90C401M

**Note 1:** "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" specifies conditions of device operation.

Note 2: Current into device pins is defined as positive. Current out of device pins is defined as negative. All voltages are referenced to ground except:  $V_{OD1}$  and  $\Delta V_{OD1}$ .

#### **Note 3:** All typicals are given for: $V_{CC} = +5.0V$ , $T_A = +25^{\circ}C$ .

**Note 4:** Channel-to-Channel Skew is defined as the difference between the propagation delay of the channel and the other channels in the same chip with an event on the inputs.

**Note 5:** Chip to Chip Skew is defined as the difference between the minimum and maximum specified differential propagation delays.

**Note 6:** Generator waveform for all tests unless otherwise specified: f = 1 MHz,  $Z_O = 50\Omega$ ,  $t_r \le 6$  ns, and  $t_f \le 6$  ns.

Note 7: ESD Ratings:

HBM (1.5 kΩ, 100 pF)  $\ge$  3,500V

EIAJ (0 $\Omega$ , 200 pF)  $\geq$  250V

Note 8: Output short circuit current ( $I_{OS}$ ) is specified as magnitude only, minus sign indicates direction only.

Note 9: C<sub>L</sub> includes probe and jig capacitance.

#### **Truth Table**

D <sub>IN</sub>	D <sub>OUT+</sub>	D <sub>OUT</sub>
L	L	Н
Н	Н	L
$D_{IN} > 0.8V$ and $D_{IN} < 2.0V$	Х	Х

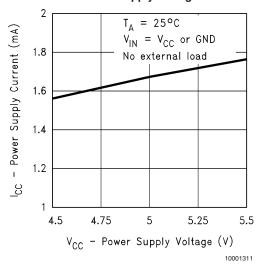
H = Logic high level

L = Logic low level

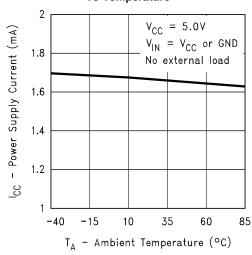
X = Indeterminant state

## **Typical Performance Characteristics**

# Power Supply Current vs Power Supply Voltage

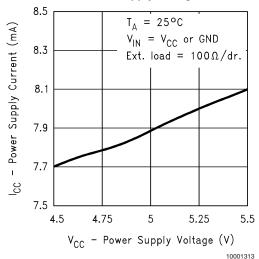


# Power Supply Current vs Temperature

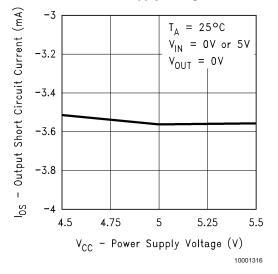


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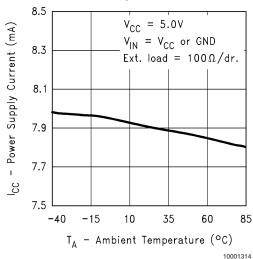
# Power Supply Current vs Power Supply Voltage



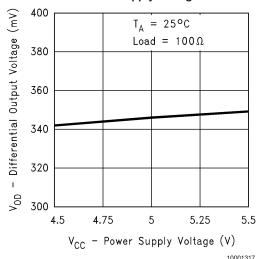
# Output Short Circuit Current vs Power Supply Voltage



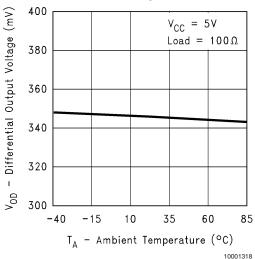
# Power Supply Current vs Temperature



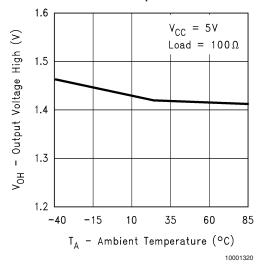
# Differential Output Voltage vs Power Supply Voltage



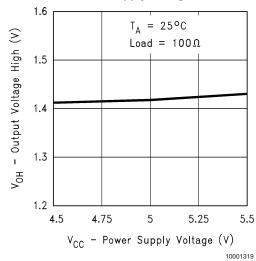
# Differential Output Voltage vs Ambient Temperature



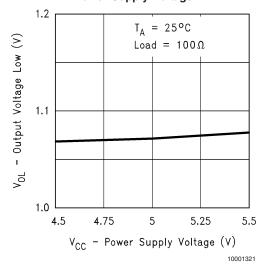
#### Output Voltage High vs Ambient Temperature



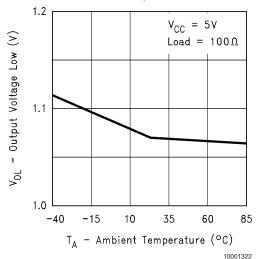
#### Output Voltage High vs Power Supply Voltage



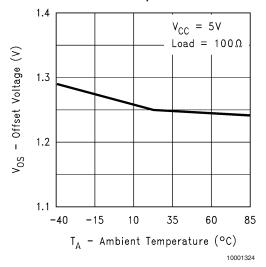
#### Output Voltage Low vs Power Supply Voltage



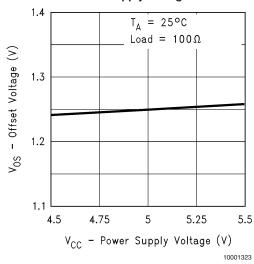
#### Output Voltage Low vs Ambient Temperature



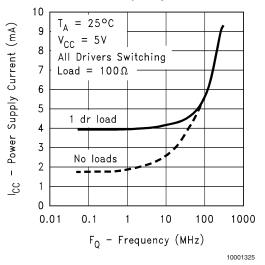
#### Offset Voltage vs Ambient Temperature



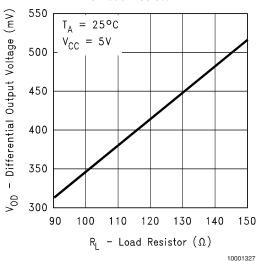
#### Offset Voltage vs Power Supply Voltage



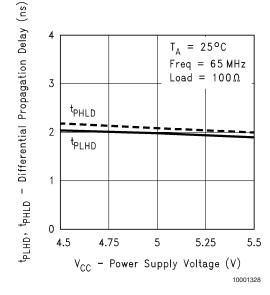
# Power Supply Current vs Frequency



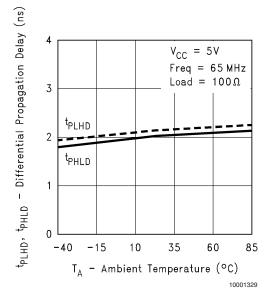
# Differential Output Voltage vs Load Resistor



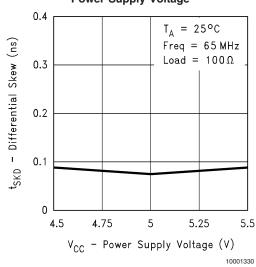
# Differential Propagation Delay vs Power Supply Voltage



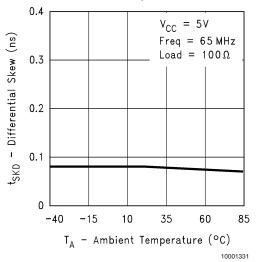
# Differential Propagation Delay vs Ambient Temperature



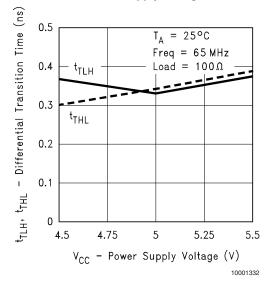
#### Differential Skew vs Power Supply Voltage



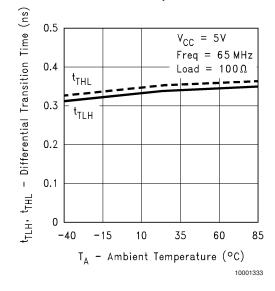
#### Differential Skew vs Ambient Temperature



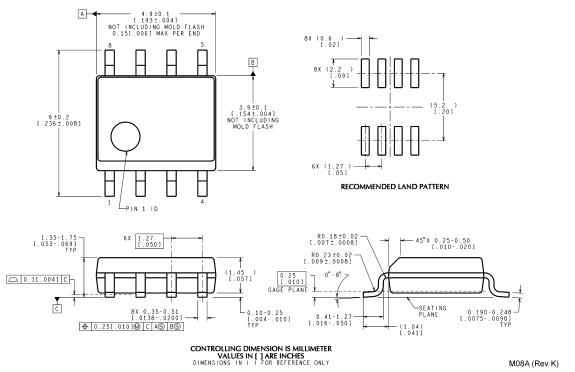
# Differential Transition Time vs Power Supply Voltage



# Differential Transition Time vs Ambient Temperature



#### Physical Dimensions inches (millimeters) unless otherwise noted



8-Lead (0.150" Wide) Molded Small Outline Package, JEDEC Order Number DS90C401M **NS Package Number M08A** 

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